

Notice of References Cited		Application/Control No. 10/572,590	Applicant(s)/Patent Under Reexamination TAKEUCHI ET AL.	
		Examiner PHOEBE RINER	Art Unit 1795	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0134200 a	07-2003	Tanaka et al.	429/231.1
*	B	US-2006/0188786 a	08-2006	Lee et al.	429/249
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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